Applicant(s)/Patent Under Application/Control No. Reexamination 10/718,896 LIN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 DAVID VU 2818 **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY US-5,426,324 06-1995 Rajeevakumar, Thekkemadathil V. 257/368 Α 08-2000 US-6,096,632 Drynan, John Mark 438/618 В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** · Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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